PD-95770

International **ICR** Rectifier

- Advanced Process Technology
- Surface Mount (IRF9Z24NS) -
- Low-profile through-hole (IRF9Z24NL)
- 175°C Operating Temperature
- P-Channel
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Description

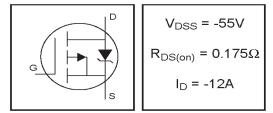
Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications. The D²Pak is a surface mount power package capable of

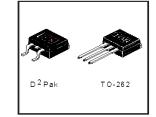
accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible onresistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application. The through-hole version (IRF9Z24NL) is available for

low-profile applications.

Absolute Maximum Ratings

IRF9Z24NSPbF **IRF9Z24NLPBF**





	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10V [©]	-12	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ -10V®	-8.5	A
I _{DM}	Pulsed Drain Current 00	-48	
P _D @T _A = 25°C	Power Dissipation	3.8	W
P _D @T _C = 25°C	Power Dissipation	45	W
	Linear Derating Factor	0.30	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy@©	96	mJ
I _{AR}	Avalanche Current®	-7.2	A
E _{AR}	Repetitive Avalanche Energy®	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt 35	-5.0	V/ns
TJ	Operating Junction and	-55 to+175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
R _{0JC}	Junction-to-Case		3.3	0.000
R _{eja}	Junction-to-Ambient (PCB Mounted,steady-state)**		40	°CW
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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-55			V	$V_{GS} = 0V, I_{D} = -250 \mu A$
ΔV _{(BR)DSS} /ΔTJ	Breakdown Voltage Temp. Coefficient		-0.05		V/°C	Reference to 25°C, I_D = -1mA ⁽³⁾
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.175	Ω	V_{GS} = -10V, I_D = -7.2A ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$
g fs	Forward Transconductance	2.5			S	V _{DS} = -25V, I _D = -7.2A
1	Drain-to-Source Leakage Current			-25	μA	$V_{DS} = -55V, V_{GS} = 0V$
DSS				-250		V_{DS} = -44V, V_{GS} = 0V, T_{J} = 150°C
1	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 20V
GSS	Gate-to-Source Reverse Leakage			-100	nA :	V _{GS} = -20V
Qg	Total Gate Charge			19		I _D = -7.2A
Q _{gs}	Gate-to-Source Charge			5.1	nC	V _{DS} = -44V
Q _{gd}	Gate-to-Drain ("Miller") Charge			10		V _{GS} = -10V, See Fig. 6 and 13 ④⑤
t _{d(on)}	Turn-On Delay Time		13			V _{DD} = -28V
tr	Rise Time		55			I _D = -7.2A
$t_{\text{d(off)}}$	Turn-Off Delay Time		23		ns	$R_G = 24\Omega$
t _f	Fall Time		37			$R_D = 3.7\Omega$, See Fig. 10 @ (3)
1.	Internal Source Inductance				nH	Between lead,
L _S		7.5			and center of die contact	
Ciss	Input Capacitance		350			V _{GS} = 0V
Coss	Output Capacitance		170		рF	V _{DS} = -25V
C _{rss}	Reverse Transfer Capacitance		92			f = 1.0MHz, See Fig. 5⑤

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			40		MOSFET symbol
	(Body Diode)			-12	A	showing the
I _{SM}	Pulsed Source Current			4.0		integral reverse 🔍 🗂
	(Body Diode) •			-48		p-n junction diode.
V _{SD}	Diode Forward Voltage			-1.6	V	$T_{\rm J}$ = 25°C, $I_{\rm S}$ = -7.2A, $V_{\rm GS}$ = 0V ④
trr	Reverse Recovery Time		47	71	ns	T _J = 25°C, I _F = -7.2A
Qrr	Reverse RecoveryCharge		84	130	nC	di/dt = -100A/µs ④⑤
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11) 0 Pulse width \leq 300 $\mu s;$ duty cycle \leq 2%.

② Starting $T_J = 25^{\circ}C$, L = 3.7mH

- ⑤ Uses IRF9Z24N data and test conditions
- $$\label{eq:RG} \begin{split} R_G &= 25\Omega, \ I_{AS} = -7.2A. \ (\text{See Figure 12}) \\ & \ \ 3 \ \ I_{SD} \leq -7.2A, \ di/dt \ \leq \ -280A/\mu s, \ V_{DD} \leq \ \ V_{(BR)DSS}, \end{split}$$
- $I_{SD} \leq -7.2A$, and $\leq -280A/\mu s$, $v_{DD} \leq v_{(BR)DSS}$, $T_{J} \leq 175^{\circ}C$
- ** When mounted on 1" square PCB (FR-4 or G-10 Material).

For recommended footprint and soldering techniques refer to application note #AN-994.

International **ISR** Rectifier

IRF9Z24NS/LPbF

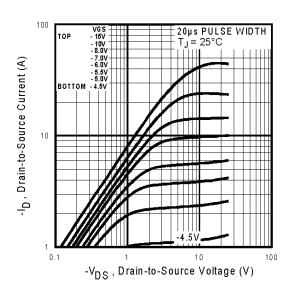


Fig 1. Typical Output Characteristics

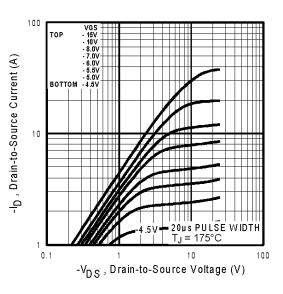


Fig 2. Typical Output Characteristics

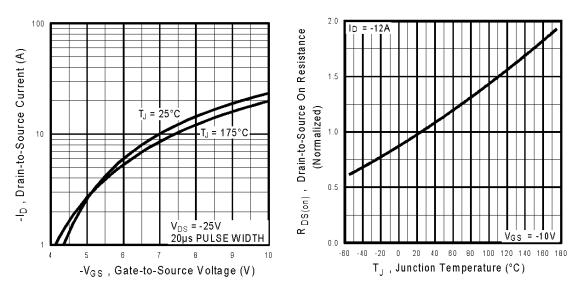


Fig 3. Typical Transfer Characteristics

Fig 4. Normalized On-Resistance Vs. Temperature



International **IGR** Rectifier

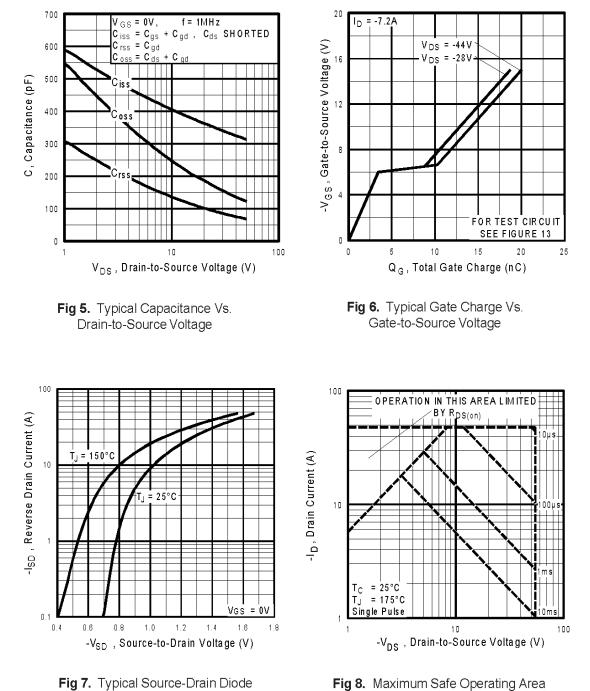


Fig 8. Maximum Safe Operating Area

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Forward Voltage

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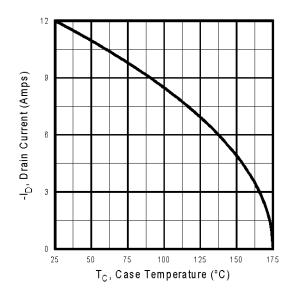


Fig 9. Maximum Drain Current Vs. Case Temperature

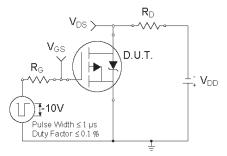


Fig 10a. Switching Time Test Circuit

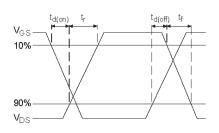


Fig 10b. Switching Time Waveforms

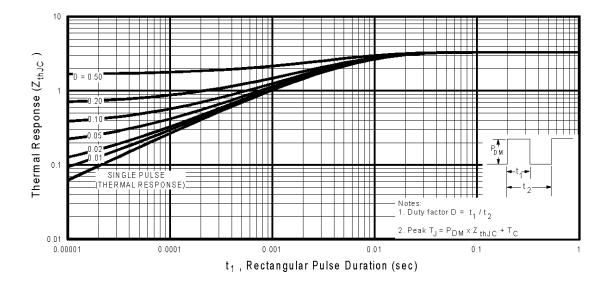


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case www.irf.com

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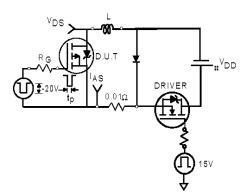


Fig 12a. Unclamped Inductive Test Circuit

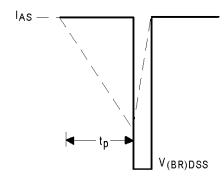


Fig 12b. Unclamped Inductive Waveforms

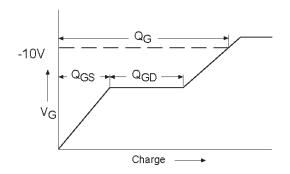


Fig 13a. Basic Gate Charge Waveform

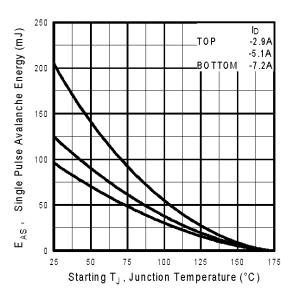


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

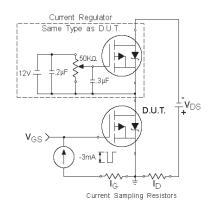
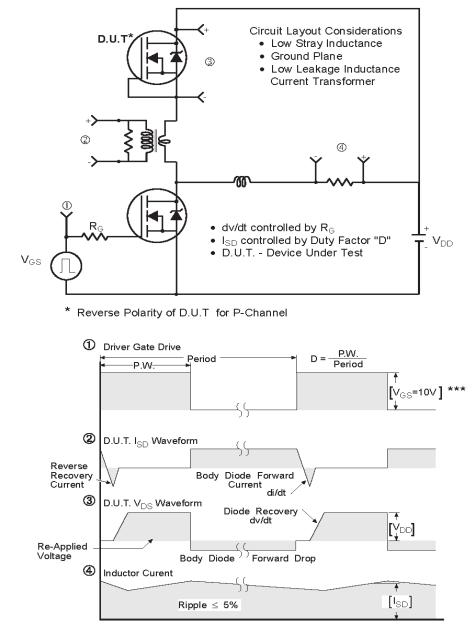


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



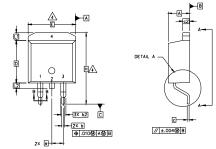
*** $V_{\rm GS}$ = 5.0V for Logic Level and 3V Drive Devices

Fig 14. For P-Channel HEXFETS

International **TOR** Rectifier

D²Pak Package Outline (Dimensions are shown in millimeters (inches)

NOTES:



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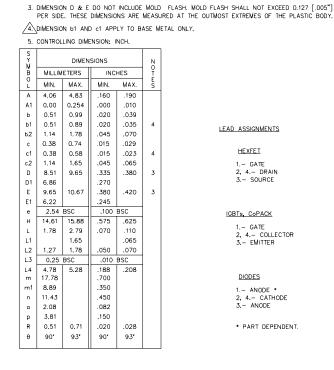
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DETAIL "A" ROTATED 90" SCALE 8:1

SECT

Π

SCALE 2:1



1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

LEAD ASSIGNMENTS

HEXFET 1.- GATE 2, 4.- DRAIN 3.- SOURCE

IGBTs, CoPACK

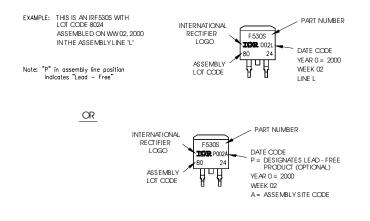
1.- GATE 2. 4.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE * 2.4.- CATHODE 3.- ANODE

* PART DEPENDENT.

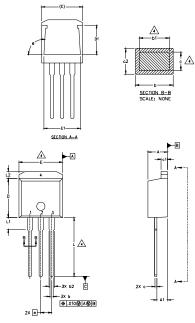
D²Pak Part Marking Information



International **ICOR** Rectifier

IRF9Z24NS/LPbF

TO-262 Package Outline (Dimensions are shown in millimeters (inches)



S Y M	DIMENSIONS				
В	MILLIM	ETERS	INCHES		O T E S
0 L	MIN.	MAX.	MIN.	MAX.	E S
А	4.06	4.83	.160	.190	
A1	2.03	2.92	.080	.115	
b	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	4
b2	1.14	1.40	.045	.055	
С	0.38	0.63	.015	.025	4
c1	1.14	1.40	.045	.055	
c2	0.43	.063	.017	.029	
D	8.51	9.65	.335	.380	3
D1	5.33		.210		
Е	9.65	10.67	.380	.420	3
E1	6.22		.245		
е	2.54 BSC		.100	BSC	
L	13.46	14.09	.530	.555	
L1	3.56	3.71	.140	.146	
L2		1.65		.065	
- 1				1 Lawrence	

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE

2.- DRAIN

4.- DRAIN

3.- SOURCE

<u>IGBT</u>

2 - COLLECTOR

3 - EMITTER

1 - GATE

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NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

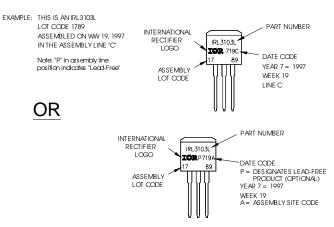
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

A. DIMENSION 61 AND C1 APPLY TO BASE METAL ONLY.

5. CONTROLLING DIMENSION: INCH.

TO-262 Part Marking Information

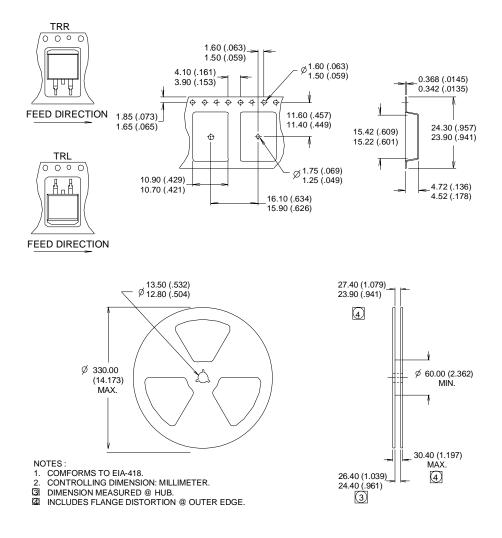


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International **ISPR** Rectifier

D²Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



Data and specifications subject to change without notice.

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